

N-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ)			
20	0.0027 at V _{GS} = 4.5 V	90	90 nC			
20	0.0038 at V _{GS} = 2.5 V	70	90 110			

FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2011/65/EU

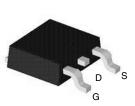


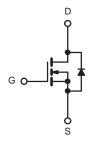


APPLICATIONS

- OR-ing
- Server
- DC/DC







N-Channel MOSFET

Top View

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	20	V	
Gate-Source Voltage		V _{GS}	± 12		
	T _C = 25 °C		90 ^{a, e}		
Continuous Drain Current (T = 175 °C)	T _C = 70 °C	,	76 ^e		
Continuous Drain Current (T _J = 175 °C)	T _A = 25 °C	I _D	26.5 ^{b, c}	A	
	T _A = 70 °C		15 ^{b, c}		
Pulsed Drain Current		I _{DM}	270		
Avalanche Current Pulse L = 0.1 mH		I _{AS}	35		
Single Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	89	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I-	90 ^{a, e}	Α	
Continuous Source-Diain Diode Current	T _A = 25 °C	I _S	2.9 ^{b, c}		
	T _C = 25 °C		225 ^a	w	
Mariana Paran Dissipation	T _C = 70 °C	В .	151		
Maximum Power Dissipation	T _A = 25 °C	P _D	3.25 ^{b, c}	vv	
	T _A = 70 °C		2.21 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 sec	R _{thJA}	35	45	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.6	0.8	-	

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.

- c. t = 10 sec.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature. Package limitation current is 90 A.



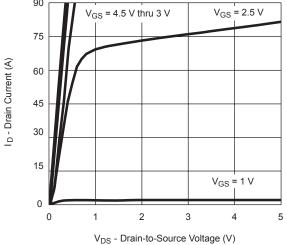
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				•		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	T _J I _D = 250 μA		35		~\\/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	1D = 230 μΑ		- 7.5		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5		1.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA
Zara Cata Valtaga Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	90			Α
	_	$V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$		0.0027	0.0035	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 20 \text{ A}$		0.0038	0.0048	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A		135		S
Dynamic ^b						
Input Capacitance	C _{iss}			8850		
Output Capacitance	C _{oss}	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		2780		pF
Reverse Transfer Capacitance	C _{rss}			830		
Total Gate Charge	Qg	$V_{DS} = 16 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 30 \text{ A}$		105		
Total Gate Charge				65		nC
Gate-Source Charge	Q_{gs}	$V_{DS} = 16 \text{ V}, V_{GS} = 2.5 \text{ V}, I_{D} = 20 \text{ A}$		32		
Gate-Drain Charge	Q_{gd}			21		
Gate Resistance	R_g	f = 1 MHz		1.5		Ω
Turn-On Delay Time	t _{d(on)}			21		
Rise Time	t _r	V_{DD} = 16 V, R_L = 0.625 Ω		15		
Turn-Off Delay Time	t _{d(off)}	$I_{D}\cong$ 30 A, V_{GEN} = 4.5 V, R_g = 1 Ω		77		
Fall Time	t _f			13		
Turn-On Delay Time	t _{d(on)}			56		ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		173		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 20$ A, $V_{GEN}=2.5$ V, $R_g=1$ Ω		58		
Fall Time	t _f			15		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			90	А
Pulse Diode Forward Current ^a	I _{SM}				270	^
Body Diode Voltage	V_{SD}	I _S = 22 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			55	80	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		73	115	nC
Reverse Recovery Fall Time	t _a	$I_F = 20 \text{ A}$, $I_J = 25 \text{ C}$		27		
	t _b			1		ns

Notes:

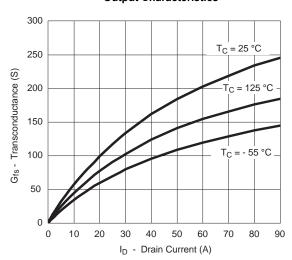
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

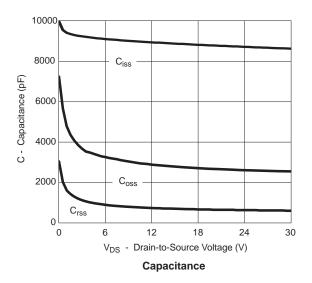
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

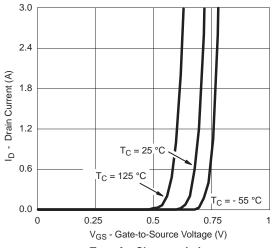


Output Characteristics

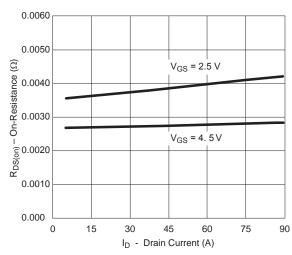


Transconductance

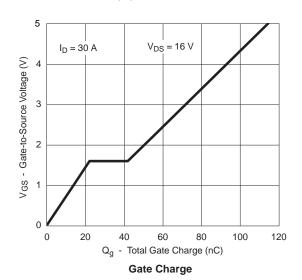




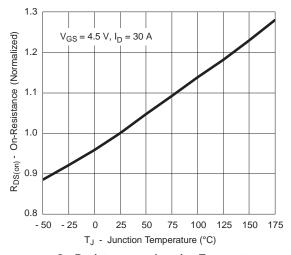
Transfer Characteristics



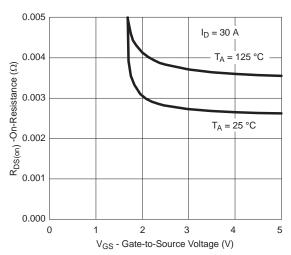
R_{DS(on)} vs. Drain Current



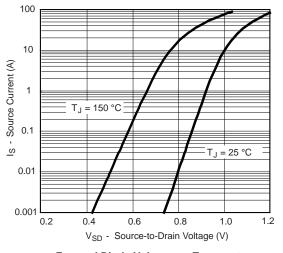
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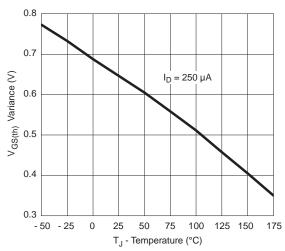
On-Resistance vs. Junction Temperature



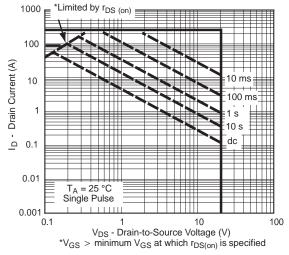
 $R_{DS(on)}$ vs. V_{GS} vs. Temperature



Forward Diode Voltage vs. Temperature

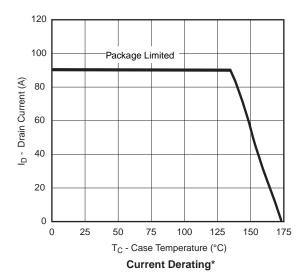


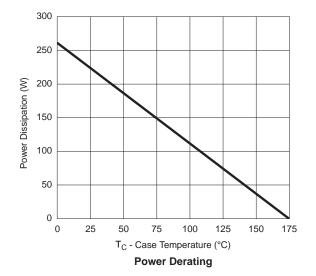
Threshold Voltage



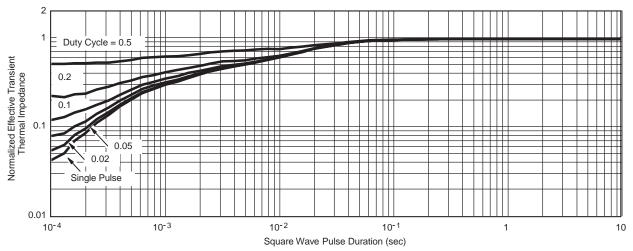
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



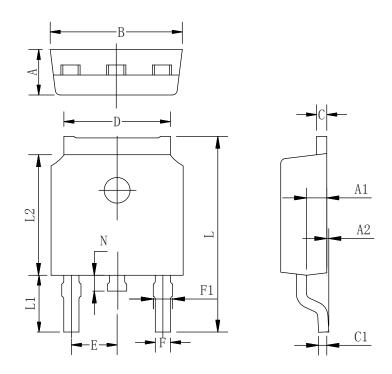


*The power dissipation P_D is based on $T_{J(max)}$ = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case

TO-252-2L PACKAGE OUTLINE



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Тур	Max	
A	2.10	2.30	2.50	
A1	0.88	1.01	1.16	
A2	0.00	0.15	0.28	
В	6.40	6.60	6.80	
С	0.42	0.50	0.63	
C1	0.42	0.50	0.63	
D	5.08	5.32	5.65	
Е	2.286 TYP			
F	0.63	0.76	0.89	
F1	0.64	0.86	1.08	
L	9.30	9.90	10.80	
L1	2.4	2.8	3.6	
L2	5.90	6.10	6.55	
N	0.57	0.80	1.05	



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